Notice of References Cited	Application/Control No. 10/532,267	Applicant(s)/Pater Reexamination NICOLAS ET AL.	nt Under	
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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0072862	04-2003	Pruden et al.	426/549
	В	US-			
	U	US-			
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	F	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
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## **NON-PATENT DOCUMENTS**

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